

PERRY JOHNSON LABORATORY ACCREDITATION, INC.

Certificate of Accreditation

Perry Johnson Laboratory Accreditation, Inc. has assessed the Laboratory of:

EQ-LAB, *S.A. de C.V.*

Los Amoles #137, Hacienda San Miguel Guadalupe, Nuevo León, México. C.P. 67113

(Hereinafter called the Organization) and hereby declares that Organization is accredited in accordance with the recognized International Standard:

ISO/IEC 17025:2017

This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (as outlined by the joint ISO-ILAC-IAF Communiqué dated April 2017):

Dimensional, Mass, Force and Weighing Devices, Mechanical, Thermodynamic, Chemical, Acoustic, Time and Frequency, Optical and Electrical Calibration (As detailed in the supplement)

Accreditation claims for such testing and/or calibration services shall only be made from addresses referenced within this certificate. This Accreditation is granted subject to the system rules governing the Accreditation referred to above, and the Organization hereby covenants with the Accreditation body's duty to observe and comply with the said rules.

For PJLA:

Tracy Szerszen President

Perry Johnson Laboratory Accreditation, Inc. (PJLA) 755 W. Big Beaver, Suite 1325 Troy, Michigan 48084 Initial Accreditation Date: October 31, 2023

Issue Date: October 31, 2023

Expiration Date: January 31, 2026

Accreditation No.: 122472

Certificate No.: L23-804

The validity of this certificate is maintained through ongoing assessments based on a continuous accreditation cycle. The validity of this certificate should be confirmed through the PJLA website: <u>www.pjlabs.com</u>

Page 1 of 14



EQ-LAB, S.A. de C.V.

Los Amoles #137, Hacienda San Miguel Guadalupe, Nuevo León, México. C.P. 67113 Contact Name Roberto Delgado Andrade Phone: 813-067-7022

Accreditation is granted to the facility to perform the following calibrations:

Dimensional

MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE (AND SPECIFICATION WHERE APPROPRIATE)	CALIBRATION OR MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED	CALIBRATION MEASUREMENT METHOD OR PROCEDURES USED
Micrometer Head ^F	Up to 50 mm	$(0.55 + 2.7 \text{ x } 10^{-3} \text{L}) \ \mu\text{m}$	Gauge Blocks Set	NMX-CH-093
Outside Micrometer ^F	Up to 2 000 mm	$(0.57 + 8.2 \text{ x } 10^{-3} \text{ L}) \ \mu\text{m}$		
Inside Micrometer ^F	Up to 2 000 mm	$(0.55 + 2.7 \text{ x } 10^{-3} \text{L}) \ \mu\text{m}$		
Internal Micrometers with Three point (Holtest) ^F	6.3 mm to 100 mm	(3.8 + 4.3 x 10 ⁻² L) μm	Steel Setting Rings	NMX CH-92
Tubular Inside Micrometer Micrometer Head ^F	Up to 25 mm	(0.57 + 1.0 x 10 ⁻³ L) μm	Gauge Blocks Set	JIS B 7508
Tubular Inside Micrometer Extensions Rods ^F	25 mm to 100 mm	(0.92 + 2.8 x 10 ⁻³ L) μm		
Depth Micrometers ^F	Up to 300 mm	$(0.57 + 6.4 \text{ x } 10^{-3} \text{L}) \ \mu\text{m}$	Gauge Blocks Set	NMX-CH-093
Calipers, Vernier Dial and Digital ^F	Up to 2 000 mm	(5.8 + 7.1 x 10 ⁻³ L) μm		
Linear Scales (Digital Rulers) ^{FO}	Up to 2 000 mm	(5.8 + 7.1 x 10 ⁻³ L) μm		
Laser Distance Meter ^{FO}	127 mm to 2 006.6 mm	(0.058 + 1.0 x 10 ⁻⁶ L) μm	Gague Blocks Set	ISO 16331-1
Telescope Gages (Only max and min values) ^{FO}	25 mm to 100 mm	(0.73 + 3.7 x 10 ⁻³ L) μm		
Height Gages Vernier, Dial and Digital ^F	Up to 1 000 mm	(6.0 + 6.0 x 10 ⁻³ L) μm	Gauge Blocks Set	NMX-CH-141
Height Master ^F	5 mm to 1 010 mm	(1.6 + 6.6 x 10 ⁻³ L) μm	Gauge Blocks Set	NMX-CH-7863
Dial and Digital Indicators ^F	Up to 25 mm	$(0.99 + 6.9 \text{ x } 10^{-2} \text{L}) \ \mu\text{m}$	Dial Gage Tester	NMX-CH-463 NMX-CH-149
Dial Test Indicator ^F	Up to 1.6 mm	$(0.99 + 6.9 \text{ x } 10^{-2} \text{L}) \ \mu\text{m}$		
Dial and Digital Bore Gage ^F	1 mm to 25 mm	(0.76 + 0.23L) μm		
Pin and Plug Gages ^F	0.25 mm to 4.7 mm	$(0.79 + 8.0 \text{ x } 10^{-4} \text{L}) \ \mu\text{m}$	Digital Indicator	Euramet_cg-6
Standard Wire Gage ^F	0.25 mm to 4.7 mm	0.79 μm		
Setting Micrometer Standard ^F	25 mm to 100 mm	(0.73 + 3.7 x 10 ⁻³ L) μm	Gague Blocks Set	JIS B 7545
Steel Thickness Gages ^F	0.04 mm to 1 mm	0.79 μm	Digital Indicator	JIS B 7524
Plastic Standard Coating Thickness Gages ^F	0.01 mm to 12.19 mm	$(0.79 + 8.0 \text{ x } 10^{-4} \text{L}) \ \mu\text{m}$	Digital Indicator	ASTM-D-1005
Issue: 10/2023	This supplement	nt is in conjunction with cer	rtificate # L23-0804	Page 2 of 14



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Dimensional MEASURED INSTRUMENT,	RANGE (AND SPECIFICATION	CALIBRATION OR MEASUREMENT	CALIBRATION EQUIPMENT AND	CALIBRATION MEASUREMENT
QUANTITY OR GAUGE	WHERE APPROPRIATE)	CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	REFERENCE STANDARDS USED	METHOD OR PROCEDURES USED
Thread Plug Gages and	2.1 mm to 46.7 mm	$(1.1 + 1.4 \text{ x } 10^{-2} \text{L}) \ \mu\text{m}$	Micrometer and Wire	ANSI B92.1
Spline Gages Pitch Diameter ^F			Set	DIN 5480 ANSI/ASME B1.2
Coating Thickness	0.01 mm to 12.19 mm	5.9 µm	Foil Thickness	Standard
Gages ^F	0.01 mm to 12.17 mm	sis pin		ASTM D7091
Measure Tape ^F	Up to 50 m	$(0.029 + 6 \text{ x } 10^{-3} \text{ L}) \text{ mm}$	Rule Standard and	JIS B 7512
Pi Tape ^F	Up to 8 m	$(0.25 + 2 \times 10^{-5} \text{L}) \text{ mm}$	Reticule	
Rulers ^F	Up to 1 000 mm	$(0.025 + 2 \times 10^{-5} \text{L}) \text{ mm}$		
Scantling Gages ^F	Up to 1 000 mm	0.29 mm	Rule Standard	
Surface RoughnessGage ^F			Precision Roughness	NMX-CH-12179
(Ra)	1 μm to 9.5 μm	$(0.77 + 1.2 \text{ x } 10^{-3}\text{L}) \ \mu\text{m}$ $(0.79 + 1.8 \text{ x } 10^{-3}\text{L}) \ \mu\text{m}$	Specimen	
Surface Roughness Gage ^F (Rz)	6.6 μm to 40 μm			
Surface Roughness Gage ^F (Rt)	8 µm to 43 µm	(0.77 + 2.3 x 10 ⁻³ L) μm		
Surface Roughness Gage ^F (Rp)	1.9 μm to 18 μm	(0.78 + 3.7 x 10 ⁻³ L) μm		
Blocks Gages Grade 1 and 2 ^F	1 mm to 100 mm	(0.6.3 + 3.7 x 10 ⁻³ L) μm	Blocks Standard Grade 0 Digital Indicator	NMX-CH-3650
4 Step Block Gage	6.35 mm to 25.4 mm	(0.73 + 3.7 x 10 ⁻³ L) μm	Blocks Standard	
Thickness Gages	Up to 25.4 mm	2.9 μm	Grade 0 Digital Indicator	
Protractor Goniometer Digital Level ^F	0° to 90°	$(0.049 + 1 \text{ x } 10^{-5} \text{L})^{\circ}$	Angle Blocks Standard	NMX-CH-151
Squares ^F	0° to 90°	0.09°	Digital Protractor	ASME Y14.5
Squares Perpendicularity ^F	Up to 300 mm	0.011 mm	Test Indicator	NMX-CH-062
Profile Projector Angle error ⁰	0° to 90°	$(0.049 + 1 \text{ x } 10^{-5} \text{L})^{\circ}$	Angle Blocks Set	JIS B 7184
Profile Projectors			Standard Glass Scales	1
X Axis error	Up to 300 mm	$(1.1 + 0.15L) \mu m$		
Y Axis error ⁰	120 / 170	(0.055 ± 4.1051)	4	
Profile Projector - Magnification ^O	120 mm to 170 mm	$(0.055 + 4 \text{ x } 10^{-5} \text{L}) \text{ mm}$		
Microscope and Vision			-	
System				
X Axis Linearity Y Axis Linearity ⁰	Up to 300 mm	(1.5 + 0.15L) μm		

Issue: 10/2023



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Surface Plates: Local Area Flatness ^O	250 mm x 250 mm to 2 500 mm x 1 600 mm	0.71 μm	Repeat Reading Gage	ЛS В 7513
Ultrasonic Thickness Gage ^F	6.35 to 25.4 mm	6.9 μm	Step Block	ASTM E797
Levels ^F	Up to 300 mm Sensitivity 0.02 mm/m	0.046 mm/m	Reference Flat Surface	DIN 877

Mass, Force and Weighing Devices

MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE (AND SPECIFICATION WHERE APPROPRIATE)	CALIBRATION OR MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED	CALIBRATION MEASUREMENT METHOD OR PROCEDURES USED
Scales and Balances ^O	Up to 50 g	0.064 mg	Weight Set	NOM-010-SCFI
	(Res.=0.05 mg)		OIML E2	
	Up to 100 g	0.089 mg		
	(Res.= 0.05 mg)			
	Up to 200 g	0.17 mg		
	(Res.= 0.1 mg)			
	Up to 500 g	0.39 mg		
	(Res.= 0.2 mg)			
	Up to 1 kg	3 mg	Weight Set	NOM-010-SCFI
	(Res.=2 mg)		OIML F1	
	Up to 2 kg	6.4 mg		
	(Res.=5 mg)			
	Up to 5 kg	15 mg		
	(Res.=10 mg)			
	Up to 10 kg	1.6 g	Weight Set	NOM-010-SCFI
	(Res.=2 g)		OIML M1	
	Up to 20 kg	4 g		
	(Res.=5 g)			
	Up to 50 kg	8.1 g		
	(Res.=10 g)			
	Up to 100 kg	16 g		
	(Res.= 20 g)	10		
	Up to 200 kg	40 g		
	(Res.=50 g)			
	Up to 500 kg $(B_{22} = 100 \text{ s})$	80 g		
	(Res.=100 g)	0.41		
	Up to 1 000 kg $(D_{22} = 500 \text{ s})$	0.4 kg		
	(Res.=500 g)			ļ]

Issue: 10/2023



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Mass, Force and Weighing Devices

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Floor, Hopper &	Up to 2 000 kg	0.8 kg	Weight Set OIML	CENAM Technical
Scales	(Res.=100 g)		M1 and Material	Guide
	Up to $6\ 000\ \text{kg}$	2.4 kg	Substitution	
	(Res.= 1 kg) Up to 10 000 kg	4 kg	-	
	(Res.=1 kg)	4 Kg		
Weight OIML Class	1 g	0.033 mg	Weight Set OIML	
F1and F2 and ASTM	2 g	0.04 mg	E2	
Class 3 and 4^{F}	5 g	0.05 mg	Double Substitution	
	10 g	0.067 mg	-	
	20 g	0.083 mg	-	
	50 g	0.1 mg		
	100 g	0.17 mg		
	200 g	0.33 mg		
	500 g	0.83 mg		
	1 000 g	1.7 mg		
Weighth OIML Class	1 g	0.33 mg	Weight Set	
M1, M2 and M3,	2 g	0.4 mg	OIML E2 and F1 Double Substitution	
ASTM Class 5, 6 and 7 ^F	5 g	0.82 mg	Double Substitution	
	10 g	0.83 mg	1)	
	20 g	0.83 mg		
	50 g	0.84 mg		
	100 g	0.88 mg		
	200 g	0.99 mg		
	500 g	1.6 mg		
	1 kg	2.9 mg		
	2 kg	9.8 mg]	
	5 kg	83 mg]	
	10 kg	86 mg]	
	20 kg	98 mg		
Force, Gages and	100 N to 1 000 N	$(0.69 + 3.8 \times 10^{-3} F)$ % of reading	Load Cells	ISO-7500-1
Instruments Only Compression ^{FO}	1 000 N to 10 000 N	$(0.69 + 4 \text{ x } 10^{-4} \text{F})$ % of reading		ASTM E4

Issue: 10/2023



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Mechanical

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Pressure / Vacuum	-14.5 psi to 0 psi	(0.59 + 4 x 10 ⁻⁴ P) psi	Pressure Gauge and Pressure Module	CENAM Technical Guide
Gages Air Medium and Water	0 psi to 36 psi	0.059 psi		
Medium ^{FO}	-1 psi to 1 psi	0.029 psi	Fluke	
	Up to 30 psi	0.29 psi		
	Up to 300 psi	1.5 psi		
	Up to 1 000 psi	5.8 psi		
	Up to 10 000 psi	58 psi		
Dynamic Viscosity	500 cP	2.1 cP	Cannon Standard Oil	ASTM D7042
Meters @25°C ^{FO}	5 000 cP	24 cP	@ 25°C	
	30 000 cP	162 cP		
Kinematic Viscosity	36 cSt	0.1 cSt	Cannon Standard Oil	ASTM D1200
Cups: Zahn, Ford, ISO,	126 cSt	0.29 cSt		ASTM D4212
ASTM, DIN, Gradco, Shell, Frikmar Saybolt @25°C ^{FO}	1 000 cSt	1.3 cSt		
Indirect Verification of	20 HRB to 50 HRB	1.1 HRB	Test Block	ISO 6508-2 ASTM E18
Rockwell Hardness	50 HRB to 80 HRB	1 HRB		
Tester HRB ^o	80 HRB to 100 HRB	0.55 HRB		
Indirect Verification of	20 HRC to 30 HRC	0.48 HRC		
Rockwell Hardness	30 HRC to 55 HRC	0.57 HRC		
Tester HRC ^o	55 HRC to 70 HRC	0.37 HRC		
Indirect Verification of Leeb Hardness Tester LD ^{FO}	365 HLD	16 HLD	Test Block	ASTM A956
Direct Verification of Durometer Shore Tester Types A, B, E & O ^F Durometer Force	0.55 N to 8.05 N	0.000 14 N	Load Cell	ASTM D2240 ISO 21509
Spring Type M	4.445 N to 44.45 N	0.000 14 N		
Type OO, OOO	0.324 N to 0.765 N	0.000 14 N		
Type OOO-S	0.203 N to 1.111 N	0.000 14 N		
Type C, D & DO	0.167 N to 1.932 N	0.000 14 N		CENAME, 1 . 10.11
Micropipettes ^F	10 μL to 200 μL	0.38 μL	Gravimetric Method Balances OHAUS	CENAM Technical Guide
	200 µL to 500 µL	0.39 μL		

Issue: 10/2023

This supplement is in conjunction with certificate # L23-804

Page 6 of 14



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Mechanical

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Micropipettes ^F	500 μL to 1 000 μL	0.42 μL	Gravimetric Method	CENAM Technical
	1 000 µL to 2 000 µL	0.52 μL	Balances OHAUS	Guide
Pipettes ^F	10 mL to 200 mL	0.018 % of reading		
Burettes ^F	10 mL to 100 mL	0.018 % of reading		
Cylinders and Cubic Cups ^F	200 mL to 1 000 mL	0.02 % of reading		
Volumetric Flasks ^F	10 mL to 100 mL	0.018 % of reading		
	200 mL to 1 000 mL	$(0.02 + 2 \times 10^{-4} \text{V}) \text{ mL}$		
	1 000 mL to 2 000 mL	0.02 % of reading		
Beakers ^F	10 mL to 200 mL	0.018 % of reading		
	200 mL to 1 000 mL	$(0.02 + 2 \times 10^{-4} \text{V}) \text{ mL}$		
	1 000 mL to 2 000 mL	0.02 % of reading		
Pycnometers ^F	10 mL to 200 mL	0.018 % of reading		
Containers ^F	1 000 mL to 20 000 mL	0.02 % of reading		
Anemometer ^F	Up to 9 m/s	(0.58 + 0.23 L) m/s	Anemometer	IEC 61400-12-1
(Air Flow)			Comparison	ASTM D5096
Torque Tools ^F	3.4 Nm to 17 Nm	(0.066 + 2.6 x 10 ⁻³ L) Nm	Torque Analyzer	Euramet_cg-14
	68 Nm to 339 Nm	$(0.75 + 6 \times 10^{-4} \text{ L}) \text{ Nm}$		

Thermodynamic				
MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE (AND SPECIFICATION WHERE APPROPRIATE)	CALIBRATION OR MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED	CALIBRATION MEASUREMENT METHOD OR PROCEDURES USED
Infrared Guns, Pyrometers and Cameras ^F	50 °C to 1 000 °C	$(0.68 + 2.7 \text{ x } 10^{-3} \text{T}) ^{\circ}\text{C}$	Precision Infrared Calibrator	CENAM Technical Guide
Bi-Metallic Thermometers ^F	-10 °C to 120 °C	0.83 °C	Dry-Well and Digital Thermometer w/ Pt- 1000	Euramet cg-20
Climatic Chambers:	30 °C to 600 °C 0 °C to 60 °C	$\frac{(0.79 + 2.8 \text{ x } 10^{-3}\text{T}) \text{ °C}}{(0.2 + 2.4 \text{ x } 10^{-3}\text{T}) \text{ °C}}$	Fluke 725 w/TC-k Reference Thermo	Euramet cg-20
Ovens, Furnaces, Mufflers, Incubators, Refrigerators, Freezers, Cold Rooms Error of Indication ^O			Hygrometer	

Issue: 10/2023



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Accreditation is granted to the facility to perform the following calibrations:

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Thermody	vnamic

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Climatic Chambers: Ovens, Furnaces,	-40 °C to 200 °C	$(0.58 + 4.0 \text{ x } 10^{-5} \text{T}) ^{\circ}\text{C}$	Digital Thermometer w/Pt-1000	Euramet cg-20
Mufflers, Incubators, Refrigerators, Freezers, Cold Rooms Error of Indication ⁰	8 °C to 800 °C	(1.1 + 2.0 x 10 ⁻³ T) °C	Fluke 725 w/TC-k	
RTDs, Rods and Probes with Thermocouple J, K, T,	-10 °C to 120 °C	0.83 °C	Dry-Well and Digital Thermometer w/ Pt-1000	
E, R, S, B, L U and N^F	35 °C to 600 °C	$(0.57 + 3.0 \text{ x } 10^{-3} \text{T}) ^{\circ}\text{C}$	Dry-Well and Fluke 725 w/TC-k	
Liquid in Glass Thermometers ^F	-25 °C to 150 °C	(0.14 + 1.0 x 10 ⁻⁴ T) °C	Bath Circulator and Digital Thermometer w/ Pt-1000	
Thermo Hygrometer ^F (Humidity)	11.5 % RH to 97.5 % RH	$(1.5 + 2.3 \text{ x } 10^{-3} \text{H})$ % RH	Reference Thermohygrometer	
Climatic Chambers (Humidity) Sensors and Recorders ^{FO}	11.5 % RH to 97.5 % RH	(0.97 + 2.3 x 10 ⁻³ H) % RH	and Humidity Chamber	
Thermo Hygrometer (Temperature) ^F	2 °C to 60 °C	0.31 °C	Reference Thermohygrometer and Temperature Chamber	
Heating Plates ^{FO}	Up to 260 °C	(1.1 + 4 x 10 ⁻⁴ T) °C	Digital Thermometer Fluke 54 w/TC-K	
Dry Well ^F	-40 °C to 200 °C	(0.58 + 4 x 10 ⁻⁵ T) °C	Digital Thermometer w/Pt-1000	
Baths Circulators ^{FO}	-40 °C to 200 °C	(0.58 + 5 x 10 ⁻⁵ T) °C	Digital Thermometer w/Pt-1000	
	35 °C to 600 °C	(0.55 + 3.1 x 10 ⁻³ T) °C	Dry-Well and Fluke 725 w/TC-k	

Chemical

MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE (AND SPECIFICATION WHERE APPROPRIATE)	CALIBRATION OR MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED	CALIBRATION MEASUREMENT METHOD OR PROCEDURES USED
pH Meter ^{FO}	4 pH	0.062 pH	Buffer Solutions	NMX-CH-166
	7 pH	0.061 pH		CEM QU-003
	10 pH	0.082 pH		

Issue: 10/2023

This supplement is in conjunction with certificate # L23-804

Page 8 of 14



EQ-LAB, S.A. de C.V. Los Amoles #137, Hacienda San Miguel Guadalupe, Nuevo León, México. C.P. 67113

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Conductivity Meter ^{FO}	1 415 μS/cm	15 μS/cm	Buffer Solution	OIML R 68
Karl Fisher Titration	1 mg/g	0.013 mg/g	Standard Solutions	ASTM E 203-01
Equipment ^O	10 mg/g	0.19 mg/g		

Acoustic

MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE (AND SPECIFICATION WHERE APPROPRIATE)	CALIBRATION OR MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED	CALIBRATION MEASUREMENT METHOD OR PROCEDURES USED
Acoustic Level	94 dB	0.37 dB	Acoustic Calibrator	IEC 61672-1
Generate (F=1 kHz) ^{FO}	104 dB	0.4 dB		NMX-CH-389-1-IMNC
$(\Gamma - 1 \text{ KHZ})^{-1}$	114 dB	0.43 dB	-	
Acoustic Level	94 dB	0.79 dB	Acoustic Calibrator	IEC 61672-1
Measurement (F=1 kHz) ^{FO}	114 dB	0.87 dB	Sonometer of Reference	NMX-CH-389-1-IMNC

Time and Frequency

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MEASURED	RANGE	CALIBRATION	CALIBRATION	CALIBRATION
INSTRUMENT,	(AND SPECIFICATION	OR MEASUREMENT	EQUIPMENT AND	MEASUREMENT METHOD
QUANTITY OR GAUGE	WHERE APPROPRIATE)	CAPABILITY EXPRESSED	REFERENCE	OR PROCEDURES USED
		AS AN UNCERTAINTY (±)	STANDARDS USED	
Equipment to Output	113 rpm to 28 800 rpm	$(0.53 + 6 \times 10^{-4} \text{V}) \text{ rpm}$	LUTRON DT-2259	CENAM Technical
Frequency ^{FO}			Digital Tachometer /	Guide
			Stroboscope AS432B	
Equipment to Output	1 s to 36 000 s	$(0.49 + 4 \text{ x } 10^{-6} \text{t}) \text{ s}$	JUNSD Stopwatch	
Time ^{FO}			ITTC-7.6-02-07	

Optical

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Ev Light Meters ^F	120 lux to 3 000 lux	$(1.1 + 2.4 \text{ x } 10^{-2} \text{ Ev}) \text{ lux}$	Luxometer	CENAM Technical Guide
Ev Illuminance ^F	260 lux to 1 880 lux	$(1 + 2.5 \text{ x } 10^{-2} \text{ Ev}) \text{ lux}$	Luxometer	ASTM E1164
Refractive Index ^F	1 °Brix to 85 °Brix	$(0.51 + 2 \times 10^{-4} B)$ % Brix	Sucrose Standards	OIML R-108
Gloss/Specular Reflectance Meter Angle of Incline ^{FO}	20° / 93.9 Gloss Units 60° / 96.5 Gloss Units 85° / 99.7 Gloss Units	0.2 Gloss Units 0.2 Gloss Units 0.23 Gloss Units	Ceram Research Gloss Standard	ASTM D523-14

Issue: 10/2023



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Accreditation is granted to the facility to perform the following calibrations:

Optical

optical					
MEASURED INSTRUMENT, QUANTITY OR GAUG	FE	RANGE (AND SPECIFICATION WHERE APPROPRIATE)	CALIBRATION OR MEASUREMENT CAPABILITY EXPRESSED	CALIBRATION EQUIPMENT AND REFERENCE	CALIBRATION MEASUREMENT METHOD OR PROCEDURES USED
X			AS AN UNCERTAINTY (±)	STANDARDS USED	
Spectrophotometers		τ: 10 %	$(0.056 + 2 \ge 10^{-5}\tau)\%\tau$	Neutral Density	CENAM Technical Guide
Transmittance ^{FO}		τ: 20 %	$(0.061 + 4 \text{ x } 10^{-5} \tau) \% \tau$	Filters, Holmium Oxide Glass	
		τ: 30 %	$(0.067 + 6 \text{ x } 10^{-5} \tau) \% \tau$	Oxide Glass	
		λ: 440 nm to 750 nm	0.05 nm		
$\rho(\lambda)$ Spectral		Color Values:		Ceramic Research	CENAM Technical Guide
Reflectance ^{FO}				Tiles	ASTM E-1164
C	IE L:	9 to 93 Units	(1.8 + 1.6 x 10 ⁻² L) Units		
	E a*:	-27 to 29 Units	(0.45 + 3.6 x 10 ⁻³ a*) Units		
	E b*:	-15 to 55 Units	(0.5 + 4.9 x 10 ⁻³ b*) Units		

El	lectrical	

Electrical				
MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE (AND SPECIFICATION WHERE APPROPRIATE)	CALIBRATION OR MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED	CALIBRATION MEASUREMENT METHOD OR PROCEDURES USED
High Voltage DC Output ⁰	2.5 kV to 35 kV	0.42 kV	Fluke 80K-40 w / Fluke 289	CENAM Technical Guide
High Voltage AC Output (60 Hz) ⁰	2.5 kV to 25 kV	0.31 kV	-0	
Temperature Calibration, Indication, and Control Equipment used with Thermocouple Type B ^{FO}	600 °C to 1 800 °C	0.46 °C	Fluke 725 Electrical Simulation of Thermocouple	Euramet_cg-11
Temperature Calibration, Indication, and Control	-200 °C to 950 °C	0.18 °C	Output	
Equipment used with Thermocouple Type E ^{FO}				
Temperature Calibration, Indication, and Control Equipment used with Thermocouple Type J ^{FO}	-200 °C to 1 200 °C	0.2 °C		
Temperature Calibration, Indication, and Control Equipment used with Thermocouple Type K ^{FO}	-200 °C to 1 370 °C	0.22 °C		
Temperature Calibration, Indication, and Control Equipment used with Thermocouple Type L ^{FO}	-200 °C to 900 °C	0.2 °C		

Issue: 10/2023



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Accreditation is granted to the facility to perform the following calibrations:

Electrical				
MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE (AND SPECIFICATION WHERE APPROPRIATE)	CALIBRATION OR MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED	CALIBRATION MEASUREMENT METHOD OR PROCEDURES USED
Temperature Calibration,	-200 °C to 400 °C	0.11 °C	Fluke 725 Electrical	Euramet_cg-11
Indication, and Control			Simulation of	
Equipment used with			Thermocouple Output	
Thermocouple Type N ^{FO}				
Temperature Calibration,	-20 °C to 1 750 °C	0.48 °C		
Indication, and Control				
Equipment used with				
Thermocouple Type R ^{FO}				
Temperature Calibration,	-20 °C to 1 750 °C	0.46 °C		
Indication, and Control				
Equipment used with				
Thermocouple Type S ^{FO}			-	
Temperature Calibration,	-250 °C to 400 °C	0.18 °C		
Indication, and Control				
Equipment used with				
Thermocouple Type T ^{FO}				
Temperature Calibration,	-200 °C to 600 °C	0.11 °C		
Indication, and Control				
Equipment used with				
Thermocouple Type U ^{FO}			4	
Temperature Calibration,	-200 °C to 800 °C	0.11 ℃	Fluke 725 Electrical	Euramet_cg-11
Indication, and Control			Simulation of RTD	
Equipment used with RTD			Output	
Type Pt 385, 100 Ω ^{FO}	0000 0000	0.10.00		
Temperature Calibration,	-80°C to 260°C	0.18 °C		
Indication, and Control				
Equipment used with RTD				
Type Pt Ni 385, 120 Ω (Ni 120) ^{FO}				
	-200 °C to 630 °C	0.11.00	-	
Temperature Calibration,	-200 °C to 030 °C	0.11 °C		
Indication, and Control Equipment used with RTD				
Equipment used with RTD Type Pt 385, 200 Ω^{FO}				
	-200 °C to 630 °C	0.11 °C	4	
Temperature Calibration, Indication, and Control	-200 °C to 030 °C	0.11 °C		
Equipment used with RTD Type Pt 385, 500 Ω^{FO}				
Temperature Calibration,	-200 °C to 630 °C	0.11 °C	4	
Indication, and Control	-200 C 10 050 C	0.11 C		
Equipment used with RTD				
Type Pt 385, 1 000 Ω^{FO}				
1 ype rt 303, 1 000 22-2	1	l		

Issue: 10/2023



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Electrical

MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE (AND SPECIFICATION WHERE APPROPRIATE)	CALIBRATION OR MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED	CALIBRATION MEASUREMENT METHOD OR PROCEDURES USED
Temperature Calibration, Indication, and Control Equipment used with RTD Type Pt 3 916, 100 Ω ^{FO}	-200 °C to 630 °C	0.11 °C	Fluke 725 Electrical Simulation of RTD Output	Euramet_cg-11
Temperature Calibration, Indication, and Control Equipment used with RTD Type Pt 3 926, 100 Ω ^{FO}	-200 °C to 630 °C	0.11 °C		
Equipment Output	10 mV to 100 mV	0.012 mV	Fluke 725	CENAM Technical Guide
DC Voltage ^{FO}	3 V to 30 V	0.006 2 V		
	5 mV to 50 mV	0.004 mV	Fluke 289	
	50 mV to 500 mV	0.17 mV	\square	
	1 V to 5 V	0.000 27 V		
	5 V to 50 V	0.001 7 V		
Equipment Output	50 V to 500 V	1.4 V	Fluke 289	
AC Voltage 60 Hz ^{FO}	100 V to 1000 V	5.8 V		
Equipment Output	4 mA to 24 mA	0.019 mA	Fluke 725	
DC Current	50 µA to 500 µA	0.55 μΑ		
	500 μA to 5000 μA	40 μΑ	Fluke 289	
	5 mA to 50 mA	0.005 5 mA		
	40 mA to 400 mA	0.19 mA		
Equipment Output	1 A to 5 A	0.000 34 A	Fluke 289	
AC Current 60 HzV	1 A to 10 A	0.001 3 A		
00112 V	1 mA to 10 mA	0.005 9 mA	ETCR7000	
	10 mA to 100 mA	0.013 mA		
	100 mA to 1000 mA	0.11 mA		
	1 A to 10 A	0.005 9 A		
	10 A to 100 A	0.013 A		
	100 A to 1000 A	0.11 A		
	1000 A to 2000 A	0.26 A		
Equipment Output	15 Ω to 3 200 Ω	4.1 Ω	Fluke 725	1
Resistance ^{FO}	5 Ω to 50 Ω	0.036 Ω	Fluke 289	1
	50 Ω to 500 Ω	0.64 Ω]	



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Accreditation is granted to the facility to perform the following calibrations:

Electrical

Electrical		r		1
MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE (AND SPECIFICATION WHERE APPROPRIATE)	CALIBRATION OR MEASUREMENT CAPABILITY EXPRESSED	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED	CALIBRATION MEASUREMENT METHOD OR PROCEDURES USED
		AS AN UNCERTAINTY (±)		
Equipment Output	1 k Ω to 5 k Ω	0.000 068 kΩ	Fluke 289	CENAM Technical Guide
Resistance ^{FO}	5 k Ω to 50 k Ω	0.004 kΩ		
	50 k Ω to 500 k Ω	0.41 kΩ		
	$1 \text{ M}\Omega$ to $5 \text{ M}\Omega$	0.027 MΩ		
	5 M Ω to 50 M Ω	2.8 MΩ		
	50 M Ω to 500 M Ω	75 ΜΩ		
Equipment Output	50 Hz to 900 Hz	0.008 5 Hz	Fluke 725	
Frequency ^{FO}	1 kHz to 10 kHz	0.001 2 kHz		
Equipment Input DC Current ^{FO}	4 mA to 24 mA	0.000 58 mA	0	
Equipment Input Resistance ^{FO}	15 Ω to 3200 Ω	4.1 Ω		
Equipment Input	50 Hz to 900 Hz	0.008 2 Hz		
Frequency ^{FO}	1 kHz to 10 kHz	0.000 13 kHz		
				•

- 1. The CMC (Calibration and Measurement Capability) stated for calibrations included on this scope of accreditation represents the smallest measurement uncertainty attainable by the laboratory when performing a more or less routine calibration of a nearly ideal device under nearly ideal conditions. It is typically expressed at a confidence level of 95 % using a coverage factor k (usually equal to 2). The actual measurement uncertainty associated with a specific calibration performed by the laboratory will typically be larger than the CMC for the same calibration since capability and performance of the device being calibrated and the conditions related to the calibration may reasonably be expected to deviate from ideal to some degree.
- 2. The laboratories range of calibration capability for all disciplines for which they are accredited is the interval from the smallest calibrated standard to the largest calibrated standard used in performing the calibration. The low end of this range must be an attainable value for which the laboratory has or has access to the standard referenced. Verification of an indicated value of zero in the absence of a standard is common practice in the procedure for many calibrations but by its definition it does not constitute calibration of zero capacity.
- 3. The presence of a superscript F means that the laboratory performs calibration of the indicated parameter at its fixed location. Example: Outside Micrometer^F would mean that the laboratory performs this calibration at its fixed location.
- 4. The presence of a superscript O means that the laboratory performs calibration of the indicated parameter onsite at customer locations. Example: Outside Micrometer^O would mean that the laboratory performs this calibration onsite at the customer's location.

Issue: 10/2023



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Accreditation is granted to the facility to perform the following calibrations:

- 5. The presence of a superscript FO means that the laboratory performs calibration of the indicated parameter both at its fixed location and onsite at customer locations. Example: Outside Micrometer^{FO} would mean that the laboratory performs this calibration at its fixed location and onsite at customer locations.
- 6. Measurement uncertainties obtained for calibrations performed at customer sites can be expected to be larger than the measurement uncertainties obtained at the laboratories fixed location for similar calibrations. This is due to the effects of transportation of the standards and equipment and upon environmental conditions at the customer site which are typically not controlled as closely as at the laboratories fixed location.
- 7. The term L represents length in inches or millimeters as appropriate to the uncertainty statement.
- 8. The term T represents temperature in °C or °F as appropriate to the uncertainty statement.
- 9. The term Wt represents weight in pounds or grams (including SI multiple and submultiple units) appropriate to the uncertainty statement.
- 10. The term H represent Relative Humidity in units of RH as appropriate to the uncertainty statement.
- 11. The term V represents Volume in liters or milliliters (including SI multiple and submultiple units) as appropriate to the uncertainty statement.
- 12. The term V represents velocity in rpm
- 13. The term t represents time in seconds (s) or millisecond (ms) as appropriate to the uncertainty statement.
- 14. The term P represents pressure in psi.
- 15. The term F represents force applied in Newton or kilogram-force